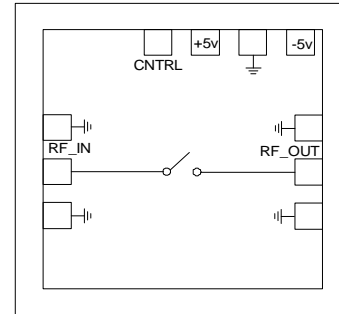


## DC–35 GHz SPST Switch

### Features

- ◆ Frequency range: DC – 35 GHz
- ◆ Low Insertion loss ~ 1.3dB @ 18 GHz
- ◆ High Isolation of 40 dB
- ◆ I/O Return loss < 15 dB
- ◆ High Input P<sub>1dB</sub>: 23 dBm
- ◆ On-Chip TTL driver for fast switching
- ◆ 0.5µm InGaAs pHEMT technology
- ◆ Chip Size : 1.73 mm x 1.13 mm x 0.10 mm

### Functional Diagram



### Typical Applications

- ◆ Military & space
- ◆ Test Equipments
- ◆ Microwave Radio, RADAR
- ◆ Broadband Telecommunications
- ◆ Commercial electronic systems

### Description

The AMT2571011 is a wideband reflective Single Pole Single Throw (SPST) switch designed over a frequency range of DC–18GHz. This switch offers high isolation and low insertion loss. It has an on-chip TTL driver for high speed switching. The RF ports are DC coupled to ensure low frequency operation. The MMIC operates on +5 V, -5 V supply voltages with very low DC power consumption. This MMIC is fabricated using highly reliable and high performance InGaAs 0.5µm pHEMT Technology.

### Absolute Maximum Ratings <sup>(1)</sup>

Parameter	Absolute Maximum	Units
RF Input Power	30	dBm
Positive Supply voltage	+6	V
Negative Supply Voltage	-6	V
Control Voltage		
ON	5 to +5.5	V
OFF	-0.5 to 0	V
Operating Temperature	-55 to +85	oC
Storage Temperature	-65 to +150	oC

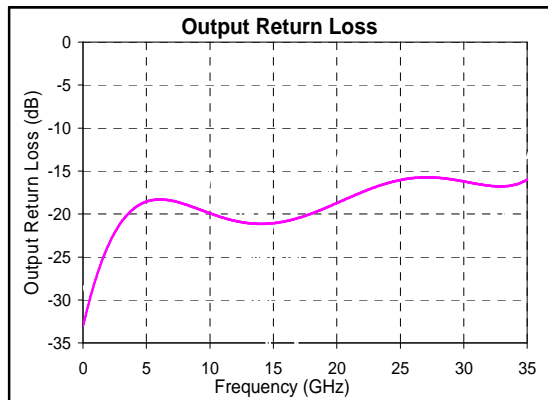
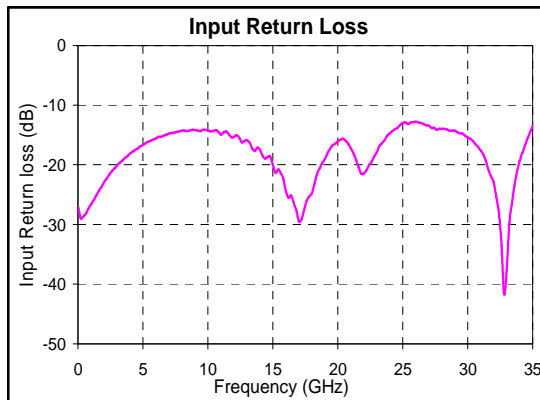
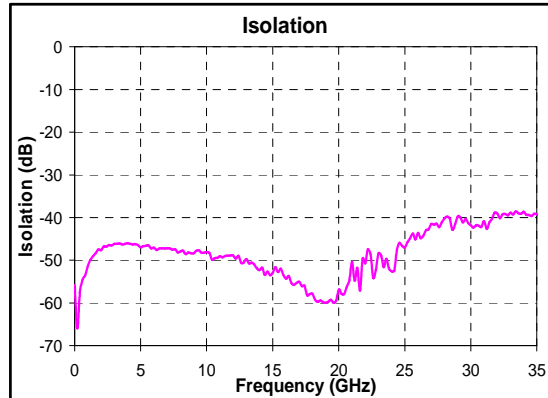
1. Operation beyond these limits may cause permanent damage to the component

**Electrical Specifications <sup>(1)</sup> @ T<sub>A</sub> = 25 °C, Z<sub>o</sub> =50 Ω**

Parameter	Frequency	Typ. Value	Units
Insertion Loss	5 GHz	0.6	dB
	10 GHz	0.8	dB
	15 GHz	1.0	dB
	18 GHz	1.2	dB
	35GHz	3.5	dB
Isolation	5 GHz	46	dB
	10 GHz	48	dB
	15 GHz	52	dB
	18 GHz	57	dB
	35GHz	40	dB
Input Return Losses	DC – 18GHz	15	dB
	DC – 35GH	13	dB
Output return Losses	DC – 18GHz	15	dB
	DC – 35GHz	13	dB
Input P1dB	DC-18GHz	23 <sup>(2)</sup>	dBm
Switching speed		40 <sup>(2)</sup>	ns
DC Bias Voltages		+5, -5	V
Control Voltage		0/+5	V

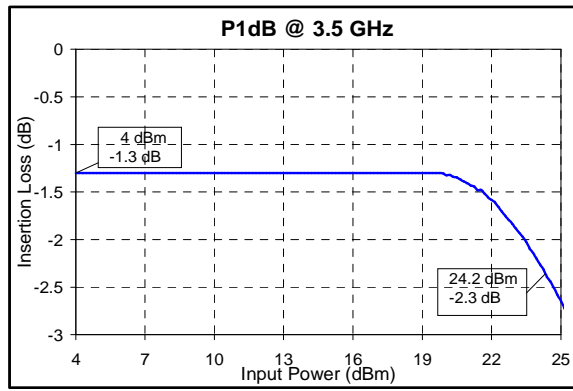
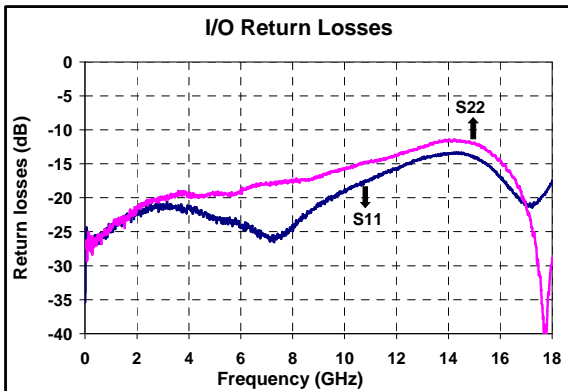
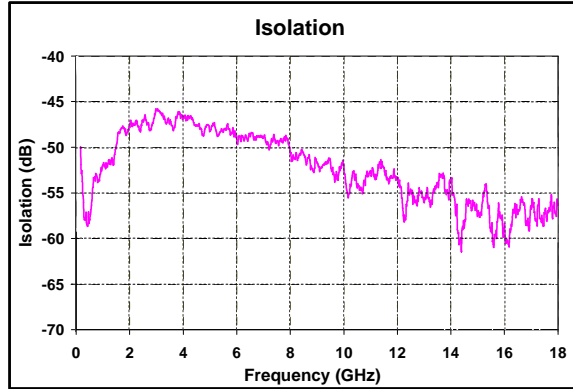
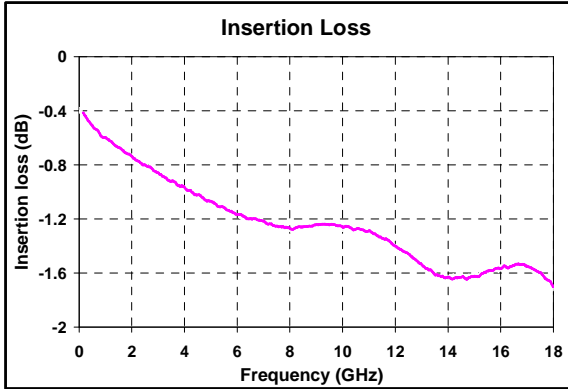
**Note:**

1. Electrical Specifications as measured On-Wafer
2. Measured in a test fixture

**On-Wafer data**
 $T_A = 25^\circ\text{C}, Z_o = 50\Omega$ 


**Test fixture data**

$T_A = 25^\circ C, Z_o = 50\Omega$



## Truth Table

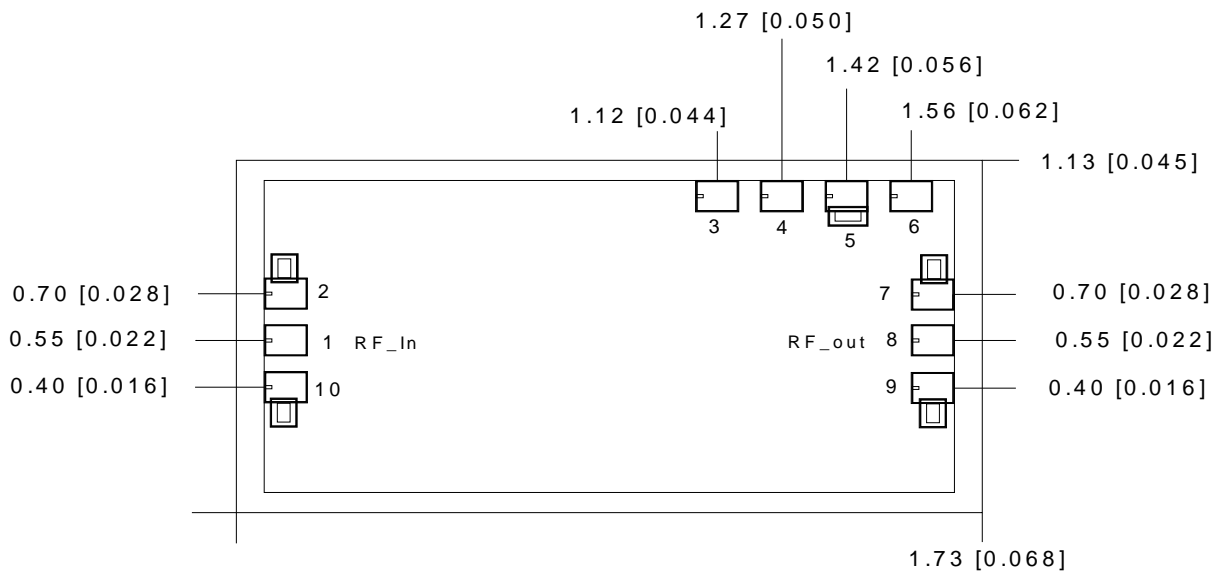
### Control Voltage

State	Bias condition
Low "0"	0 - 0.5V
High "1"	3.5 - 5

### Truth Table

Ctrl_vol	RF_In to RF_Out
0(Low)	Off ( Isolation )
1(High)	On ( Low loss )

## Mechanical Characteristics



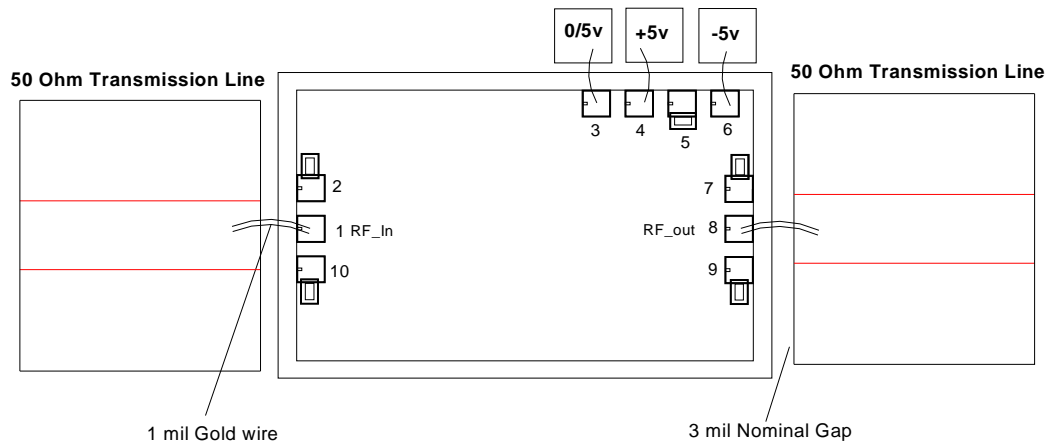
**Units: millimeters [inches]**

**All RF and DC bond pads are 100µm x 100µm**

**Note:**

1. Pad no. 1 : RF In
2. Pad no. 8 : RF Out
3. Pad no. 3 : Control Voltage
4. Pad no. 4 : +5V
5. Pad no. 6 : -5V

## Recommended Assembly Diagram



### Note:

1. Both the RF ports are DC Coupled.
2. Two 1 mil (25.4 $\mu$ m) bond wires of minimum length should be used for RF input and output.
3. For reliable operation, 0.1 $\mu$ F capacitors can be used at the voltage supplies

**Die attach:** For Epoxy attachment, use of a two-component conductive epoxy is recommended. An epoxy fillet should be visible around the total die periphery. If Eutectic attachment is preferred, use of fluxless AuSn (80/20) 1-2 mil thick preform solder is recommended. Use of AuGe preform should be strictly avoided.

**Wire bonding:** For DC pad connections use either ball or wedge bonds. For best RF performance, use of 150 - 200 $\mu$ m length of wedge bonds is advised. Single Ball bonds of 250-300 $\mu$ m though acceptable, may cause a deviation in RF performance.



**GaAs MMIC devices are susceptible to Electrostatic discharge. Proper precautions should be observed during handling, assembly & testing**

All information and Specifications are subject to change without prior notice